## Applicant(s)/Patent Under Application/Control No. Reexamination 10/643,934 LEE ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Thoi V. Duong 2871 **U.S. PATENT DOCUMENTS Document Number** Date Name Classification Country Code-Number-Kind Code MM-YYYY Α US-6,331,881 B1 12-2001 Hatano et al. 349/86 В US-С US-US-D Ε US-US-F G US-US-Н US-1 J US-Κ US-US-US-М FOREIGN PATENT DOCUMENTS Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY 'N 0 Р Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U ٧

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Х